

NTB35N15T4 Datasheet



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DiGi Electronics Part Number NTB35N15T4-DG

Manufacturer onsemi

Manufacturer Product Number NTB35N15T4

Description MOSFET N-CH 150V 37A D2PAK

Detailed Description N-Channel 150 V 37A (Ta) 2W (Ta), 178W (Tj) Surfac

e Mount D2PAK



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Purchase and inquiry

Manufacturer Product Number:	Manufacturer:
NTB35N15T4	onsemi
Series:	Product Status:
	Obsolete
FET Type:	Technology:
N-Channel	MOSFET (Metal Oxide)
Drain to Source Voltage (Vdss):	Current - Continuous Drain (Id) @ 25°C:
150 V	37A (Ta)
Drive Voltage (Max Rds On, Min Rds On):	Rds On (Max) @ Id, Vgs:
10V	50mOhm @ 18.5A, 10V
Vgs(th) (Max) @ ld:	Gate Charge (Qg) (Max) @ Vgs:
4V @ 250μA	100 nC @ 10 V
Vgs (Max):	Input Capacitance (Ciss) (Max) @ Vds:
±20V	3200 pF @ 25 V
FET Feature:	Power Dissipation (Max):
	2W (Ta), 178W (Tj)
Operating Temperature:	Mounting Type:
-55°C ~ 150°C (TJ)	Surface Mount
Supplier Device Package:	Package / Case:
D2PAK	TO-263-3, D2PAK (2 Leads + Tab), TO-263AB
Base Product Number:	
NTR35	

Environmental & Export classification

8541.29.0095

RoHS Status:	Moisture Sensitivity Level (MSL):
RoHS non-compliant	1 (Unlimited)
REACH Status:	ECCN:
REACH Unaffected	EAR99
HTSUS:	

MOSFET – N-Channel, Enhancement Mode, D²PAK 37 A, 150 V

Features

- Source-to-Drain Diode Recovery Time Comparable to a Discrete Fast Recovery Diode
- Avalanche Energy Specified
- I_{DSS} and R_{DS(on)} Specified at Elevated Temperature
- Mounting Information Provided for the D²PAK Package
- Pb-Free Packages are Available

Typical Applications

- PWM Motor Controls
- Power Supplies
- Converters

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Rating	Symbol	Value	Unit
Drain-to-Source Voltage	V _{DSS}	150	Vdc
Drain-to-Source Voltage (R _{GS} = 1.0 MΩ)	V_{DGR}	150	Vdc
Gate-to-Source Voltage - Continuous - Non-Repetitive (t _p ≤ 10 ms)	V _{GS} V _{GSM}	±20 ±40	Vdc
Drain Current - Continuous @ T _A = 25°C - Continuous @ T _A = 100°C - Pulsed (Note 2)	I _D I _D I _{DM}	37 23 111	Adc
Total Power Dissipation @ T _A = 25°C Derate above 25°C Total Power Dissipation @ T _A = 25°C (Note 1)	P _D	178 1.43 2.0	W W/°C W
Operating and Storage Temperature Range	T _J , T _{stg}	-55 to +150	°C
Single Pulse Drain–to–Source Avalanche Energy – Starting T_J = 25°C (V_{DD} = 100 Vdc, V_{GS} = 10 Vdc, $I_{L(pk)}$ = 21.6 A, L = 3.0 mH, R_G = 25 Ω)	E _{AS}	700	mJ
Thermal Resistance - Junction-to-Case - Junction-to-Ambient - Junction-to-Ambient (Note 1)	$egin{array}{c} R_{ heta JC} \ R_{ heta JA} \ R_{ heta JA} \end{array}$	0.7 62.5 50	°C/W
Maximum Lead Temperature for Soldering Purposes, 1/8 in from case for 10 seconds	TL	260	°C

Maximum ratings are those values beyond which device damage can occur. Maximum ratings applied to the device are individual stress limit values (not normal operating conditions) and are not valid simultaneously. If these limits are exceeded, device functional operation is not implied, damage may occur and reliability may be affected.

 When surface mounted to an FR4 board using the minimum recommended pad size, (Cu. Area 0.412 in²).

1



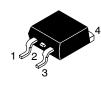
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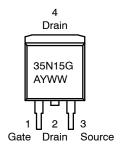
37 AMPERES, 150 VOLTS 50 m Ω @ V_{GS} = 10 V

N-Channel DO GO

MARKING DIAGRAM & PIN ASSIGNMENT



D²PAK CASE 418B STYLE 2



35N15 = Device Code A = Assembly Location

Y = Year
WW = Work Week
G = Pb-Free Package

ORDERING INFORMATION

Device	Package	Shipping [†]
NTB35N15	D ² PAK	50 Units/Rail
NTB35N15G	D ² PAK (Pb-Free)	50 Units/Rail
NTB35N15T4	D ² PAK	800 Tape & Reel
NTB35N15T4G	D ² PAK (Pb-Free)	800 Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

2.	2. Pulse Test: Pulse Width = 10 μs, Duty Cycle = 2%.	

ELECTRICAL CHARACTERISTICS ($T_C = 25^{\circ}C$ unless otherwise noted)

Ch	Symbol	Min	Тур	Max	Unit	
OFF CHARACTERISTICS						
Drain-to-Source Breakdown Volt $(V_{GS} = 0 \text{ Vdc}, I_D = 250 \mu\text{Adc})$ Temperature Coefficient (Positive)	V _{(BR)DSS}	150 -	_ 240	_ _	Vdc mV/°C	
Zero Gate Voltage Drain Current (V _{GS} = 0 Vdc, V _{DS} = 150 Vdc, (V _{GS} = 0 Vdc, V _{DS} = 150 Vdc,		I _{DSS}	_ _	- -	5.0 50	μAdc
Gate-Body Leakage Current (V _G	_S = ±20 Vdc, V _{DS} = 0)	I _{GSS}	_	-	±100	nAdc
ON CHARACTERISTICS						
Gate Threshold Voltage $V_{DS} = V_{GS}$, $I_D = 250 \mu Adc$) Temperature Coefficient (Negative)			2.0	2.9 -8.56	4.0	Vdc mV/°C
Static Drain-to-Source On-State Resistance (V_{GS} = 10 Vdc, I_D = 18.5 Adc) (V_{GS} = 10 Vdc, I_D = 18.5 Adc, T_J = 125°C)		R _{DS(on)}	_ _	0.042	0.050 0.120	Ω
Drain-to-Source On-Voltage (V _{GS} = 10 Vdc, I _D = 18.5 Adc)		V _{DS(on)}	-	1.55	1.78	Vdc
Forward Transconductance (V _{DS}	9FS	-	26	-	mhos	
DYNAMIC CHARACTERISTICS						
Input Capacitance	$(V_{DS} = 25 \text{ Vdc}, V_{GS} = 0 \text{ Vdc},$	C _{iss}	_	2275	3200	pF
Output Capacitance	f = 1.0 MHz)	C _{oss}	_	450	650	
Reverse Transfer Capacitance]	C _{rss}	_	90	175	
SWITCHING CHARACTERISTICS	(Notes 3 & 4)					
Turn-On Delay Time	(V _{DD} = 120 Vdc, I _D = 37 Adc,	t _{d(on)}	_	20	35	ns
Rise Time	$V_{GS} = 10 \text{ Vdc},$ $R_G = 9.1 \Omega)$	t _r	_	125	225	
Turn-Off Delay Time]	t _{d(off)}	_	90	175	
Fall Time]	t _f	-	120	210	
Total Gate Charge	(V _{DS} = 120 Vdc, I _D = 37 Adc,	Q _{tot}	-	70	100	nC
Gate-to-Source Charge	V _{GS} = 10 Vdc)	Q _{gs}	_	14	_	
Gate-to-Drain Charge]	Q _{gd}	_	32	_	
BODY-DRAIN DIODE RATINGS (I	Note 3)					
Diode Forward On-Voltage	$(I_S = 37 \text{ Adc}, V_{GS} = 0 \text{ Vdc})$ $(I_S = 37 \text{ Adc}, V_{GS} = 0 \text{ Vdc}, T_J = 125^{\circ}\text{C})$	V_{SD}	-	1.00 0.88	1.5 -	Vdc
Reverse Recovery Time	$(I_S = 37 \text{ Adc}, V_{GS} = 0 \text{ Vdc},$	t _{rr}	-	170	-	ns
	dI _S /dt = 100 A/μs)	t _a	-	112	-	
		t _b	-	58	-	
Reverse Recovery Stored Charge		Q _{RR}	-	1.14	_	μC

Pulse Test: Pulse Width = 300 μs max, Duty Cycle = 2%.
 Switching characteristics are independent of operating junction temperature.

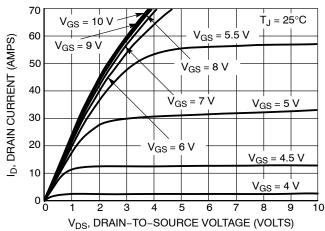


Figure 1. On-Region Characteristics

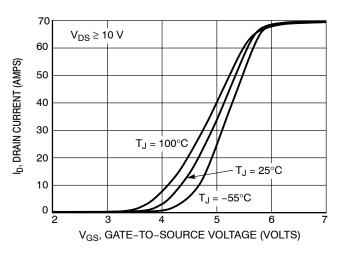


Figure 2. Transfer Characteristics

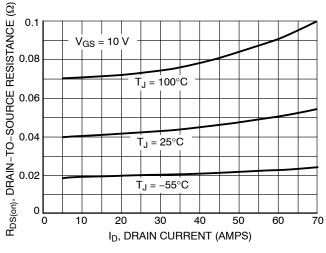


Figure 3. On-Resistance versus Drain Current and Temperature

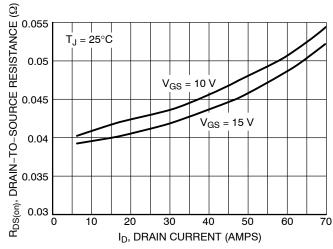


Figure 4. On-Resistance versus Drain Current and Gate Voltage

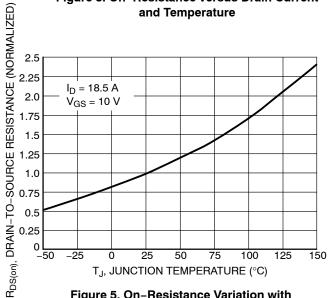


Figure 5. On-Resistance Variation with **Temperature**

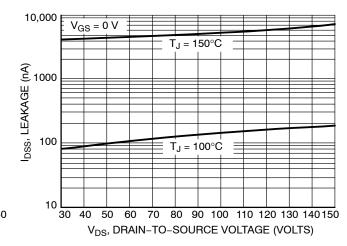


Figure 6. Drain-to-Source Leakage Current versus Voltage

POWER MOSFET SWITCHING

Switching behavior is most easily modeled and predicted by recognizing that the power MOSFET is charge controlled. The lengths of various switching intervals (Δt) are determined by how fast the FET input capacitance can be charged by current from the generator.

The published capacitance data is difficult to use for calculating rise and fall because drain–gate capacitance varies greatly with applied voltage. Accordingly, gate charge data is used. In most cases, a satisfactory estimate of average input current ($I_{G(AV)}$) can be made from a rudimentary analysis of the drive circuit so that

$$t = Q/I_{G(AV)}$$

During the rise and fall time interval when switching a resistive load, V_{GS} remains virtually constant at a level known as the plateau voltage, V_{SGP} Therefore, rise and fall times may be approximated by the following:

$$t_r = Q_2 x R_G/(V_{GG} - V_{GSP})$$

$$t_f = Q_2 x R_G/V_{GSP}$$

where

 V_{GG} = the gate drive voltage, which varies from zero to V_{GG} R_G = the gate drive resistance

and Q₂ and V_{GSP} are read from the gate charge curve.

During the turn-on and turn-off delay times, gate current is not constant. The simplest calculation uses appropriate values from the capacitance curves in a standard equation for voltage change in an RC network. The equations are:

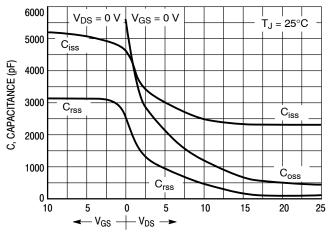
$$t_{d(on)} = R_G C_{iss} In \left[V_{GG}/(V_{GG} - V_{GSP})\right]$$

 $t_{d(off)} = R_G C_{iss} In (V_{GG}/V_{GSP})$

The capacitance (C_{iss}) is read from the capacitance curve at a voltage corresponding to the off-state condition when calculating $t_{d(on)}$ and is read at a voltage corresponding to the on-state when calculating $t_{d(off)}$.

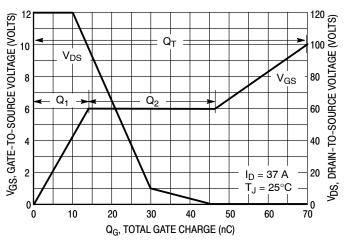
At high switching speeds, parasitic circuit elements complicate the analysis. The inductance of the MOSFET source lead, inside the package and in the circuit wiring which is common to both the drain and gate current paths, produces a voltage at the source which reduces the gate drive current. The voltage is determined by Ldi/dt, but since di/dt is a function of drain current, the mathematical solution is complex. The MOSFET output capacitance also complicates the mathematics. And finally, MOSFETs have finite internal gate resistance which effectively adds to the resistance of the driving source, but the internal resistance is difficult to measure and, consequently, is not specified.

The resistive switching time variation versus gate resistance (Figure 9) shows how typical switching performance is affected by the parasitic circuit elements. If the parasitics were not present, the slope of the curves would maintain a value of unity regardless of the switching speed. The circuit used to obtain the data is constructed to minimize common inductance in the drain and gate circuit loops and is believed readily achievable with board mounted components. Most power electronic loads are inductive; the data in the figure is taken with a resistive load, which approximates an optimally snubbed inductive load. Power MOSFETs may be safely operated into an inductive load; however, snubbing reduces switching losses.



GATE-TO-SOURCE OR DRAIN-TO-SOURCE VOLTAGE (VOLTS)

Figure 7. Capacitance Variation



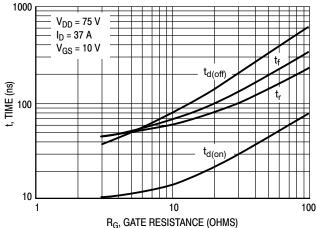


Figure 8. Gate-To-Source and Drain-To-Source
Voltage versus Total Charge

Figure 9. Resistive Switching Time Variation versus Gate Resistance

DRAIN-TO-SOURCE DIODE CHARACTERISTICS

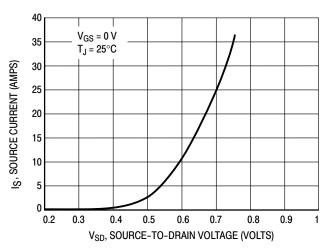


Figure 10. Diode Forward Voltage versus Current

SAFE OPERATING AREA

The Forward Biased Safe Operating Area curves define the maximum simultaneous drain-to-source voltage and drain current that a transistor can handle safely when it is forward biased. Curves are based upon maximum peak junction temperature and a case temperature (T_C) of 25°C. Peak repetitive pulsed power limits are determined by using the thermal response data in conjunction with the procedures discussed in AN569, "Transient Thermal Resistance – General Data and Its Use."

Switching between the off-state and the on-state may traverse any load line provided neither rated peak current (I_{DM}) nor rated voltage (V_{DSS}) is exceeded and the transition time (t_p , t_f) do not exceed 10 μ s. In addition the total power averaged over a complete switching cycle must not exceed ($T_{J(MAX)} - T_C$)/($R_{\theta JC}$).

A Power MOSFET designated E-FET can be safely used in switching circuits with unclamped inductive loads. For

reliable operation, the stored energy from circuit inductance dissipated in the transistor while in avalanche must be less than the rated limit and adjusted for operating conditions differing from those specified. Although industry practice is to rate in terms of energy, avalanche energy capability is not a constant. The energy rating decreases non–linearly with an increase of peak current in avalanche and peak junction temperature.

Although many E–FETs can withstand the stress of drain–to–source avalanche at currents up to rated pulsed current (I_{DM}), the energy rating is specified at rated continuous current (I_{D}), in accordance with industry custom. The energy rating must be derated for temperature as shown in the accompanying graph (Figure 12). Maximum energy at currents below rated continuous I_{D} can safely be assumed to equal the values indicated.

SAFE OPERATING AREA

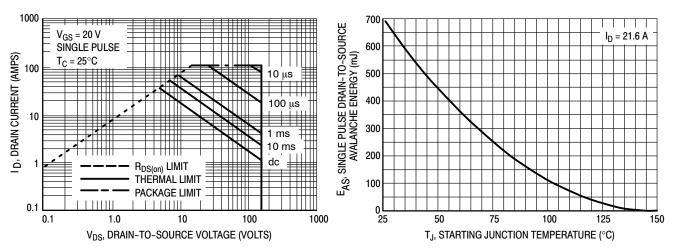


Figure 11. Maximum Rated Forward Biased Safe Operating Area

Figure 12. Maximum Avalanche Energy versus Starting Junction Temperature

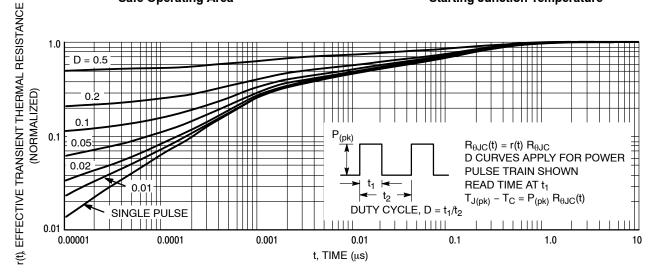


Figure 13. Thermal Response

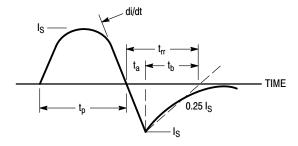


Figure 14. Diode Reverse Recovery Waveform

MECHANICAL CASE OUTLINE

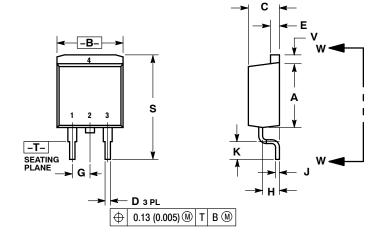
PACKAGE DIMENSIONS



D²PAK 3 CASE 418B-04 **ISSUE L**

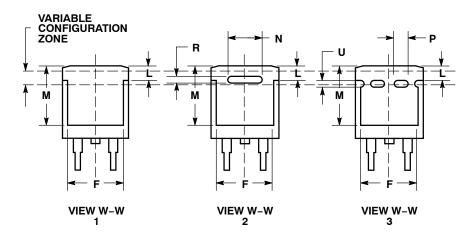
DATE 17 FEB 2015

SCALE 1:1



- DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
 CONTROLLING DIMENSION: INCH.
- 3. 418B-01 THRU 418B-03 OBSOLETE, NEW STANDARD 418B-04.

	INCHES		MILLIN	IETERS
DIM	MIN	MAX	MIN	MAX
Α	0.340	0.380	8.64	9.65
В	0.380	0.405	9.65	10.29
С	0.160	0.190	4.06	4.83
D	0.020	0.035	0.51	0.89
Е	0.045	0.055	1.14	1.40
F	0.310	0.350	7.87	8.89
G	0.100 BSC		2.54 BSC	
Н	0.080	0.110	2.03 2.79	
7	0.018	0.025	0.46	0.64
K	0.090	0.110	2.29	2.79
L	0.052	0.072	1.32	1.83
М	0.280	0.320	7.11	8.13
N	0.197 REF		5.00 REF	
P	0.079 REF		2.00 REF	
R	0.039 REF		0.99 REF	
S	0.575	0.625	14.60	15.88
٧	0.045	0.055	1.14	1.40



STYLE 1: PIN 1. BASE 2. COLLECTOR
3. EMITTER
4. COLLECTOR STYLE 2: PIN 1. GATE 2. DRAIN 3. SOURCE 4. DRAIN STYLE 3:

STYLE 4: PIN 1. ANODE 2. CATHODE 3. ANODE 4. CATHODE

PIN 1. GATE 2. COLLECTOR 3. EMITTER 4. COLLECTOR

STYLE 5: PIN 1. CATHODE 2. ANODE 3. CATHODE 4. ANODE

STYLE 6: PIN 1. NO CONNECT 2. CATHODE 3. ANODE 4. CATHODE

MARKING INFORMATION AND FOOTPRINT ON PAGE 2

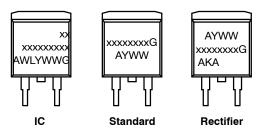
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D²PAK 3 CASE 418B-04 ISSUE L

DATE 17 FEB 2015

GENERIC MARKING DIAGRAM*

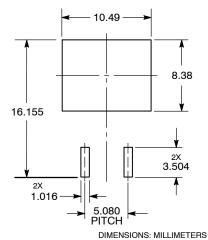


= Specific Device Code ХX = Assembly Location

= Wafer Lot WL = Year WW = Work Week G = Pb-Free Package **AKA** = Polarity Indicator

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.

SOLDERING FOOTPRINT*



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^{*}For additional information on our Pb-Free strategy and soldering details, please download the onsemi Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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